



Image

2829

P2001, 0103

CERTIFICATION OF MAILING

I hereby certify that this correspondence for Serial No. 10/076,977 is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, Va. 22313-1450

By: 

Date: January 14, 2004

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applic. No.: 10/076,977 Confirmation No: 1416
Applicant : Udo Hartmann
Filed : February 15, 2002
Title : Test System for Conducting a Function Test of a
Semiconductor Element on a Wafer, and Operating
Method
Art Unit : 2829
Examiner : Paresh H. Patel
Docket No. : P2001,0103 Customer No.: 24131

A M E N D M E N T

Mail Stop No Fee Amendment
Hon. Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

S i r :

Responsive to the Office Action dated October 15, 2003, kindly amend the above-identified application as follows:

Amendments to the Specification begin on page 2 of this paper.

Amendments to the Claims are reflected in the listing of claims which begins on page 4 of this paper.

Amendments to the Drawings begin on page 11 of this paper and include both an attached replacement sheet and an annotated sheet showing changes.

Remarks/Arguments begin on page 12 of this paper.

An **Appendix** including amended drawing figures is attached following page 22 of this paper.